

Notice of References Cited	Application/Control No. 10/761,694		Applicant(s)/Patent Under Reexamination LEE, SEUNG-WOO	
	Examiner Steven E. Holton		Art Unit 2629	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,825,824	11-2004	Lee, Baek-woon	345/89
*	B	US-2003/0193460	10-2003	Lee et al.	345/87
*	C	US-7,071,930	07-2006	Kondo et al.	345/204
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	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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